



#### **COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET**

## **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub> Max T <sub>A</sub> = +25°C	
Q2	30V	8.5A		
QZ	307	$32m\Omega$ @ $V_{GS}$ = $4.5V$	7.2A	
Q1	201/	39mΩ @ V <sub>GS</sub> = -		-7A
ζi	-30V	$53\text{m}\Omega$ @ V <sub>GS</sub> = -4.5V	-5.6A	

### **Description and**

This MOSFET has been designed to minimize the on-state resistance (R<sub>DS(on)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

- **Power Management Functions**
- Analog Switch
- Load Switch

#### **Features**

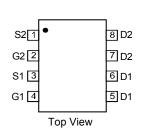
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

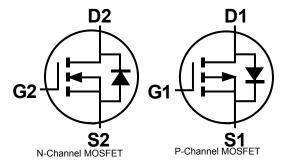
#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper lead frame Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.072 grams (approximate)









#### Ordering Information (Note 4)

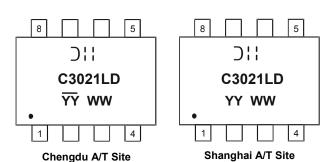
Part Number	Case	Packaging
DMC3021LSD-13	SO-8	2500/Tape & Reel

SO-8

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# **Marking Information**



⊃¦¦ = Manufacturer's Marking C3021LD = Product Type Marking Code YYWW = Date Code Marking YY or  $\overline{YY}$  = Year (ex: 14 = 2014) WW = Week (01 - 53)

YY = Date Code Marking for SAT (Shanghai Assembly/ Test site) YY = Date Code Marking for CAT (Chengdu Assembly/ Test site)



# 

Char	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	30	V
Gate-Source Voltage	$V_{GSS}$	±20	V
Continuous Drain Current (Note 5)	I <sub>D</sub>	8.5 7.1	А
Pulsed Drain Current (Note 6)	I <sub>DM</sub>	26	Α

# Maximum Ratings P-CHANNEL – Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Char	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-30	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 5)	I <sub>D</sub>	-7.0 -4.5	А
Pulsed Drain Current (Note 6)	I <sub>DM</sub>	-25	Α

# Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	P <sub>D</sub>	2.5	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	50	°C/W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C

# **Electrical Characteristics N-CHANNEL – Q2** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

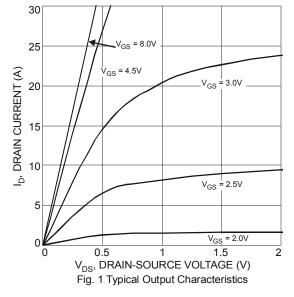
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	1.0	μA	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	$V_{GS(th)}$	1	1.45	2.1	V	$V_{DS} = V_{GS}$ , $I_C = 250\mu A$
Static Drain-Source On-Resistance	D		14	21	mΩ	$V_{GS} = 10V, I_C = 7A$
Static Dialit-Source Off-Nesistance	R <sub>DS (ON)</sub>	_	18	32	11122	$V_{GS} = 4.5V, I_C = 5.6A$
Forward Transfer Admittance	Y <sub>fs</sub>	_	8.1	_	S	$V_{DS}$ = 5V, $I_C$ = 7A
Diode Forward Voltage (Note 7)	$V_{SD}$	_	0.7	1.0	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1A
DYNAMIC CHARACTERISTICS (Note 8)			_			
Input Capacitance	C <sub>iss</sub>	_	767		pF	101/11/01/
Output Capacitance	Coss	_	110	_	pF	$V_{DS} = 10V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	Crss	_	105	_	pF	1 - 1.0Wi iz
Gate Resistance	Rg	_	1.4	_	Ω	V <sub>DS</sub> = 0V, V <sub>GS</sub> = 0V, f = 1MHz
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg		7.8	_	nC	
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	16.1	_	nC	V <sub>DS</sub> = 15V, I <sub>D</sub> = 9A
Gate-Source Charge	Q <sub>gs</sub>	_	1.8	_	nC	V <sub>DS</sub> = 15V, I <sub>D</sub> = 9A
Gate-Drain Charge	$Q_{gd}$	_	2.5	_	nC	
Turn-On Delay Time	t <sub>D(on)</sub>		5.0	_	ns	
Turn-On Rise Time	t <sub>r</sub>	_	4.5	_	ns	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15V,
Turn-Off Delay Time	t <sub>D(off)</sub>	_	26.3	_	ns	$R_G = 6\Omega$ , $I_D = 1A$
Turn-Off Fall Time	t <sub>f</sub>	_	8.55	_	ns	]

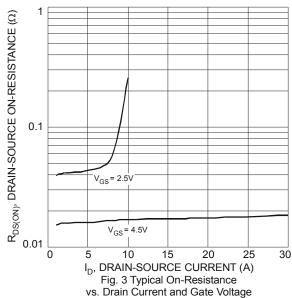
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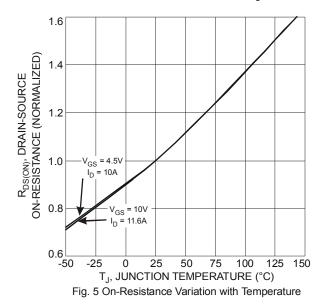
Notes:

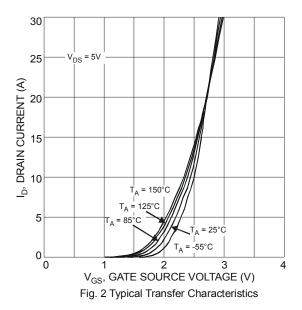
- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout.
- 6. Repetitive rating, pulse width limited by junction temperature.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.











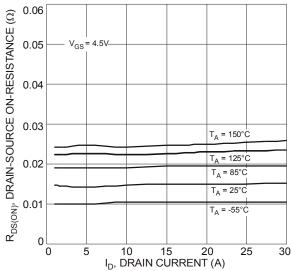


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

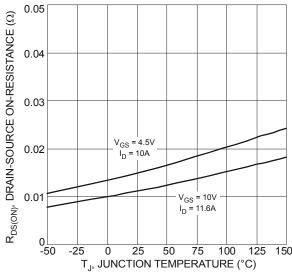


Fig. 6 On-Resistance Variation with Temperature



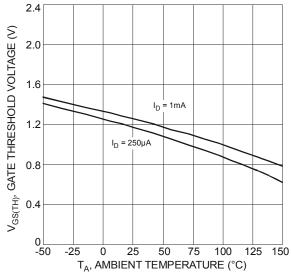
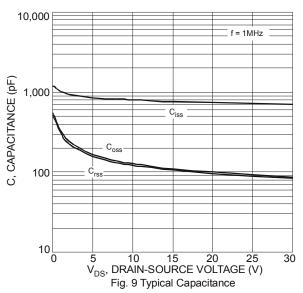
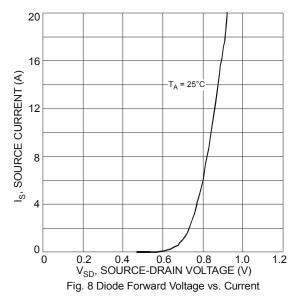


Fig. 7 Gate Threshold Variation vs. Ambient Temperature





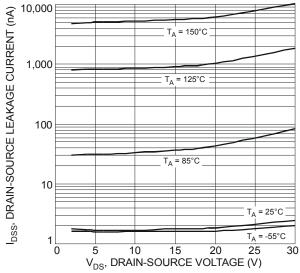


Fig. 10 Typical Drain-Source Leakage Current vs. Drain-Source Voltage

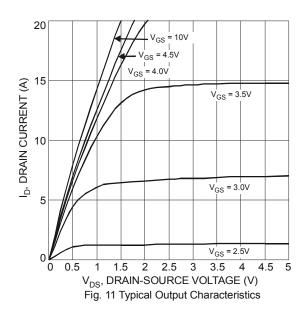


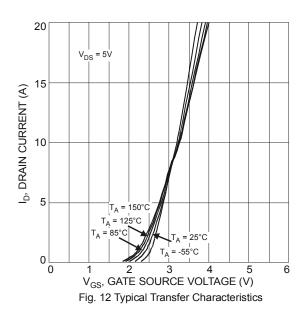
# Electrical Characteristics P-CHANNEL – Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	-1.0	μΑ	V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V
Gate-Source Leakage	I <sub>GSS</sub>		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						·
Gate Threshold Voltage	$V_{GS(th)}$	-1	-1.7	-2.2	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance	D-s (s)		30	39	mΩ	$V_{GS} = -10V$ , $I_D = -4.3A$
Static Dialii-Source Off-Resistance	R <sub>DS(ON)</sub>	_	42	53	11122	$V_{GS} = -4.5V, I_D = -3.7A$
Forward Transfer Admittance	Y <sub>fs</sub>		7	_	S	$V_{DS} = -5V, I_D = -4.3A$
Diode Forward Voltage (Note 7)	$V_{SD}$	_	-0.75	-1.0	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = -1.7A
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C <sub>iss</sub>	_	1002	_	pF	101/11/ 01/
Output Capacitance	Coss		125	_	pF	$V_{DS} = -10V, V_{GS} = 0V,$ - f = 1.0MHz
Reverse Transfer Capacitance	C <sub>rss</sub>	_	118	_	pF	1 - 1.000112
Gate Resistance	Rg	_	13	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	10.1	_	nC	
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	21.1	_	nC	\\ - 15\\ \ - 60
Gate-Source Charge	Q <sub>gs</sub>	_	2.8	_	nC	$-V_{DS} = -15V, I_{D} = -6A$
Gate-Drain Charge	Q <sub>gd</sub>	_	3.2	_	nC	
Turn-On Delay Time	t <sub>D(on)</sub>		10.1	_	ns	
Turn-On Rise Time	t <sub>r</sub>		6.5	_	ns	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V,
Turn-Off Delay Time	t <sub>D(off)</sub>	_	50.1	_	ns	$R_G = 6\Omega$ , $I_D = -1A$
Turn-Off Fall Time	t <sub>f</sub>		22.2	_	ns	

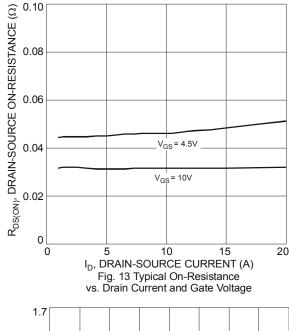
Notes: 7. Short duration pulse test used to minimize self-heating effect.

<sup>8.</sup> Guaranteed by design. Not subject to production testing.









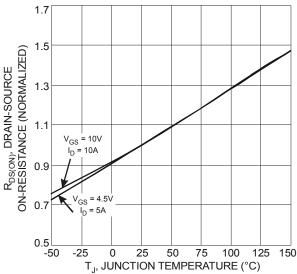


Fig. 15 On-Resistance Variation with Temperature

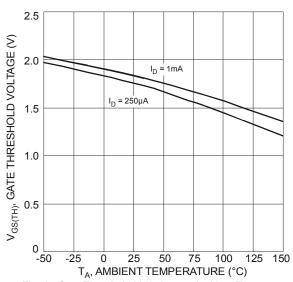


Fig. 17 Gate Threshold Variation vs. Ambient Temperature

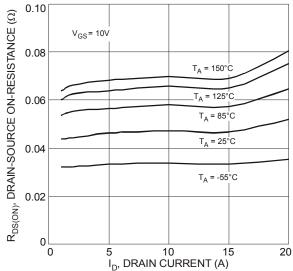


Fig. 14 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

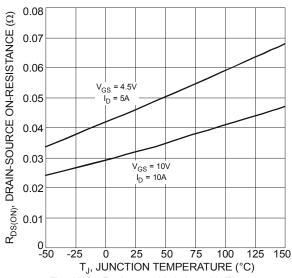


Fig. 16 On-Resistance Variation with Temperature

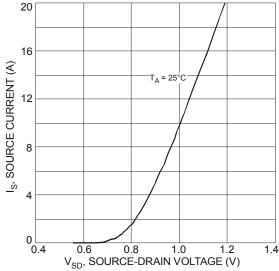
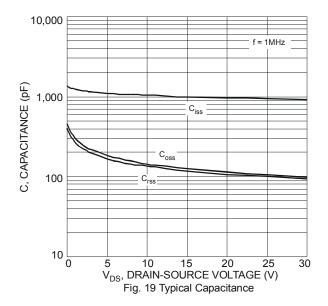
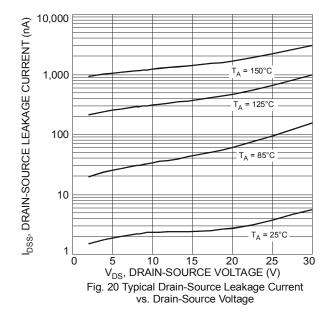


Fig. 18 Diode Forward Voltage vs. Current

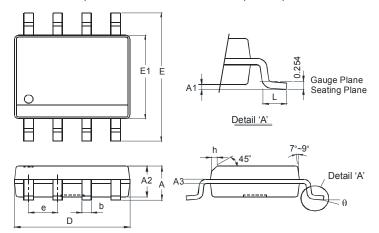






## **Package Outline Dimensions**

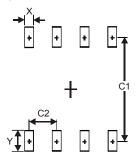
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8						
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
А3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
Е	5.90	6.10				
E1	3.85	3.95				
е	1.27	Тур				
h	-	0.35				
L	0.62	0.82				
θ	0°	8°				
All Dimensions in mm						

## **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)
X	0.60
Υ	1.55
C1	5.4
C2	1.27



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